

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination FORNARA ET AL.	
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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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N	WO 86/05187	09-1986	Europe	Howell	C07H 3/00
O	WO 2004/111170	12-2004	Europe	Fornara et al	C11D 3/386
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